February 1996

O NON-INVERTING

DS34C87T CMOS Quad TRI-STATE Differential Line Driver

DS34C87T CMOS Quad TRI-STATE® Differential Line Driver

General Description

The DS34C87T is a quad differential line driver designed for digital data transmission over balanced lines. The DS34C87T meets all the requirements of EIA standard RS-422 while retaining the low power characteristics of CMOS. This enables the construction of serial and terminal interfaces while maintaining minimal power consumption.

The DS34C87T accepts TTL or CMOS input levels and translates these to RS-422 output levels. This part uses special output circuitry that enables the individual drivers to power down without loading down the bus. This device has separate enable circuitry for each pair of the four drivers. The DS34C87T is pin compatible to the DS3487T.

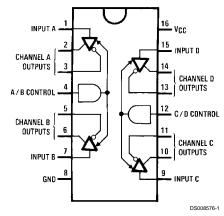
All inputs are protected against damage due to electrostatic discharge by diodes to $\rm V_{\rm CC}$ and ground.

Features

- TTL input compatible
- Typical propagation delays: 6 ns
- Typical output skew: 0.5 ns
- Outputs won't load line when V_{CC} = 0V
- Meets the requirements of EIA standard RS-422
- Operation from single 5V supply
- TRI-STATE outputs for connection to system buses
- Low quiescent current
- Available in surface mount

Connection and Logic Diagrams

Dual-In-Line Package



Top View
Order Number DS34C87TJ, DS34C87TM or
DS34C87TN
See NS Package Number J16A, M16A or N16E

OUTPUTS OUTPUT CONTROL DS008576-2

Truth Table

Input	Control Input	Non-Inverting Output	Inverting Output
Н	Н	Н	L
L	Н	L	Н
X	L	Z	z

- L = Low logic state
- H = High logic state
- X = Irrelevant
- Z = TRI-STATE (high performance)

© 1997 National Semiconductor Corporation

TRI-STATE® is a registered trademark of National Semiconductor Corporation.

www.national.com

ional.com

No. 1 **Proof**

Absolute Maximum Ratings (Notes 1,

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Supply Voltage (V_{CC}) DC Voltage (V_{IN}) -1.5 to $V_{\rm CC}$ +1.5V DC Output Voltage (V_{OUT}) -0.5 to 7VClamp Diode Current (I_{IK} , I_{OK}) ±20 mA DC Output Current, per pin (I_{OUT}) ±150 mA DC V_{CC} or GND Current (I_{CC}) ±150 mA Storage Temperature Range (T_{STG}) -65°C to +150°C Maximum Power Dissipation (PD) @ 25°C (Note 3)

Ceramic "J" Package 2419 mW

Plastic "N" Package 1736 mW SOIC Package 1226 mW Lead Temperature (T_L) (Soldering 4 sec) 260°C This device does not meet 2000V ESD rating. (Note 12)

Operating Conditions

	Min	Max	Units
Supply Voltage (V _{CC})	4.50	5.50	V
DC Input or Output Voltage (V _{IN} , V _{OUT})	0	V_{CC}	V
Operating Temperature Range (T _A)			
DS34C87T	-40	+85	°C
Input Rise or Fall Times (t _r , t _f)		500	ns

DC Electrical Characteristics (Note 4)

 V_{CC} = 5V ±10% (unless otherwise specified)

Symbol	Parameter		Conditions	Min	Тур	Max	Units
V _{IH}	High Level Input			2.0			V
	Voltage						
V _{IL}	Low Level Input					0.8	V
	Voltage						
V _{OH}	High Level Output	V _{IN} = V _{IH} or \	/ _{IL} ,	2.5	3.4		V
	Voltage	$I_{OUT} = -20 \text{ m}$	A				
V _{OL}	Low Level Output	V _{IN} = V _{IH} or \	/ _{IL} ,		0.3	0.5	V
	Voltage	I _{OUT} = 48 mA					
V _T	Differential Output	R _L = 100 Ω		2.0	3.1		V
	Voltage	(Note 5)					
$ V_T - \overline{V}_T $	Difference In	R _L = 100 Ω				0.4	V
	Differential Output	(Note 5)					
V _{os}	Common Mode	R _L = 100 Ω			2.0	3.0	V
	Output Voltage	(Note 5)					
Vos−V os	Difference In	R _L = 100 Ω				0.4	V
	Common Mode Output	(Note 5)					
I _{IN}	Input Current	V _{IN} = V _{CC} , GI	ND, V _{IH} , or V _{IL}			±1.0	μA
I _{cc}	Quiescent Supply	$I_{OUT} = 0 \mu A$					
	Current	V _{IN} = V _{CC} or GND			200	500	μΑ
		V _{IN} = 2.4V or 0.5V (Note 6)			0.8	2.0	mA
I _{oz}	TRI-STATE Output	V _{OUT} = V _{CC} or GND			±0.5	±5.0	μA
	Leakage Current	Control = V _{IL}					
I _{SC}	Output Short	V _{IN} = V _{CC} or GND		-30		-150	mA
	Circuit Current	(Note 5) (Note 7)					
I _{OFF}	Power Off Output	V _{CC} = 0V	V _{OUT} = 6V			100	μA
	Leakage Current	(Note 5)	$V_{OUT} = -0.25V$			-100	μΑ

Note 1: Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, all voltages are referenced to ground. All currents into device pins are positive; all currents out of device pins are negative.

Note 3: Ratings apply to ambient temperature at 25°C. Above this temperature derate N Package 13.89 mW/°C, J Package 16.13 mW/°C, and M Package

Note 4: Unless otherwise specified, min/max limits apply across the -40°C to 85°C temperature range. All typicals are given for V_{CC} = 5V and T_A = 25°C.

Note 5: See EIA Specification RS-422 for exact test conditions.

Note 6: Measured per input. All other inputs at V_{CC} or GND.

Note 7: This is the current sourced when a high output is shorted to ground. Only one output at a time should be shorted.

Switching Characteristics (Note 4)

 V_{CC} = 5V ±10%, t_r , $t_f \le 6$ ns (Figures 1, 2, 3, 4)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t _{PLH} , t _{PHL}	Propagation Delay	S1 Open		6	11	ns
	Input to Output					
Skew	(Note 8)	S1 Open		0.5	3	ns
t _{TLH} , t _{THL}	Differential Output Rise	S1 Open		6	10	ns
	And Fall Times					
t _{PZH}	Output Enable Time	S1 Closed		12	25	ns
t _{PZL}	Output Enable Time	S1 Closed		13	26	ns
t _{PHZ}	Output Disable Time (Note 9)	S1 Closed		4	8	ns
t _{PLZ}	Output Disable Time (Note 9)	S1 Closed		6	12	ns
C _{PD}	Power Dissipation			100		pF
	Capacitance (Note 10)					
C _{IN}	Input Capacitance			6		pF

Note 8: Skew is defined as the difference in propagation delays between complementary outputs at the 50% point.

Note 9: Output disable time is the delay from the control input being switched to the output transistors turning off. The actual disable times are less than indicated due to the delay added by the RC time constant of the load.

Note 10: C_{PD} determines the no load dynamic power consumption, $P_D = C_{PD} \ V^2CC \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC} \ V_{CC}$

Comparison Table of Switching Characteristics into "LS-Type" Load (Note 11)

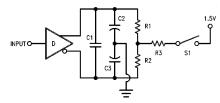
 V_{CC} = 5V, T_A = +25°C, $t_r \le 6$ ns, $t_f \le 6$ ns (Figures 4, 5, 6, 7, 8, 9)

Symbol	Parameter	Conditions	DS34C87		DS3487		Units
			Тур	Max	Тур	Max	
t _{PLH} , t _{PHL}	Propagation Delay		6	10	10	15	ns
	Input to Output						
Skew	(Note 8)		1.5	2.0			ns
t _{THL} , t _{TLH}	Differential Output Rise		4	7	10	15	ns
	and Fall Times						
t _{PHZ}	Output Disable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	8	11	17	25	ns
	(Note 9)	S1 Closed, S2 Closed					
t _{PLZ}	Output Disable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	7	10	15	25	ns
	(Note 9)	S1 Closed, S2 Closed					
t _{PZH}	Output Enable Time	$C_L = 50 \text{ pF}, R_L = \infty,$	11	19	11	25	ns
		S1 Open, S2 Closed					
t _{PZL}	Output Enable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	14	21	15	25	ns
		S1 Closed, S2 Open					

Note 11: This table is provided for comparison purposes only. The values in this table for the DS34C87 reflect the performance of the device but are not tested or guaranteed.

Note 12: ESD Rating: HBM (1.5 k Ω , 100 pF) Inputs \geq 1500V Outputs \geq 1000V EIAJ (0 Ω , 200 pF) All Pins \geq 350V

AC Test Circuit and Switching Time Waveforms



Note: C1 = C2 = C3 = 40 pF (including Probe and Jig Capacitance), R1 = R2 = 50Ω , R3 = 500Ω

FIGURE 1. AC Test Circuit

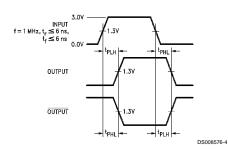


FIGURE 2. Propagation Delays

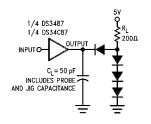


FIGURE 5. Propagation Delays Test Circuit for "LS-Type" Load

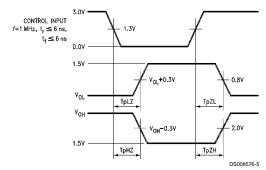


FIGURE 3. Enable and Disable Times

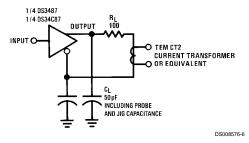


FIGURE 6. Differential Rise and Fall Times Test Circuit for "LS-Type" Load

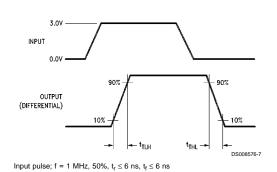


FIGURE 4. Differential Rise and Fall Times

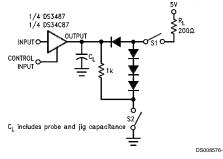


FIGURE 7. Load Enable and Disable Times Test Circuit for "LS-Type" Load

AC Test Circuit and Switching Time Waveforms (Continued)

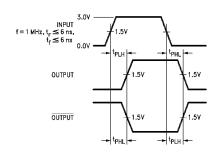


FIGURE 8. Load Propagation Delays for "LS-Type" Load

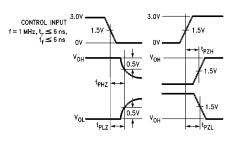
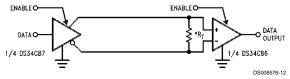


FIGURE 9. Load Enable and Disable Times for "LS-Type" Load

Typical Applications



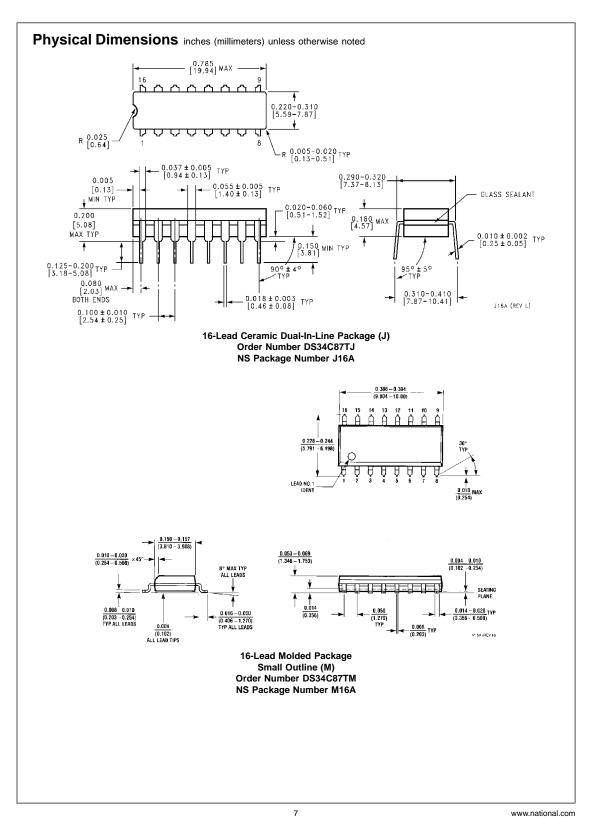
 ${}^{\star}R_{T}$ is optional although highly recommended to reduce reflection.

Book Extract End

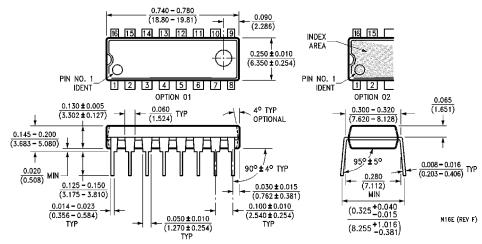
DS008576-11

PrintDate=1997/05/23 PrintTime=17:12:00 8354 ds008576 Rev. No. 1 **Proof**

THIS PAGE IS IGNORED IN THE DATABOOK



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



16-Lead Molded Dual-In-Line Package (N) Order Number DS34C87TN NS Package Number N16E

LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DE-VICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF NATIONAL SEMI-CONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



National Semiconductor Corporation

Americas Tel: 1-800-272-9959 Fax: 1-800-737-7018 Email: support@nsc.com

www.national.com

National Semiconductor

Fax: +49 (0) 1 80-530 85 86

Fax: +49 (0) 1 80-530 85 86 Email: europe. support@nsc.com Deutsch Tel: +49 (0) 1 80-530 85 85 English Tel: +49 (0) 1 80-532 78 32 Français Tel: +49 (0) 1 80-532 93 58 Italiano Tel: +49 (0) 1 80-534 16 80

National Semiconductor Hong Kong Ltd.

13th Floor, Straight Block, Ocean Centre, 5 Canton Rd. Tsimshatsui, Kowloon Hong Kong Tel: (852) 2737-1600 Fax: (852) 2736-9960

National Semiconductor Japan Ltd.

Tel: 81-3-5620-6175 Fax: 81-3-5620-6179

National does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.